# **BLF6G10-135RN**; **BLF6G10LS-135RN**

**Power LDMOS transistor** 

Rev. 01 — 10 February 2009

**Product data sheet** 

#### 1. Product profile

#### 1.1 General description

135 W LDMOS power transistor for base station applications at frequencies from 800 MHz to 1000 MHz.

Table 1. Typical performance

Typical RF performance at  $T_{case}$  = 25 °C in a class-AB production test circuit.

Mode of operation	f	$V_{DS}$	P <sub>L(AV)</sub>	Gp	$\eta_{D}$	ACPR
	(MHz)	(V)	(W)	(dB)	(%)	(dBc)
2-carrier W-CDMA	869 to 894	28	26.5	21.0	28.0	_39 <u>[1]</u>

<sup>[1]</sup> Test signal: 3GPP; test model 1; 64 DPCH; PAR = 7.5 dB at 0.01 % probability on CCDF per carrier; carrier spacing 5 MHz.

#### **CAUTION**



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

#### 1.2 Features

- Typical 2-carrier W-CDMA performance at frequencies of 869 MHz and 894 MHz, a supply voltage of 28 V and an I<sub>Dq</sub> of 950 mA:
  - ◆ Average output power = 26.5 W
  - Power gain = 21.0 dB
  - ◆ Efficiency = 28.0 %
  - ◆ ACPR = -39 dBc
- Easy power control
- Integrated ESD protection
- Enhanced ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (800 MHz to 1000 MHz)
- Internally matched for ease of use
- Compliant to Directive 2002/95/EC, regarding restriction of hazardous substances (RoHS)



### 1.3 Applications

■ RF power amplifiers for GSM, GSM EDGE, W-CDMA and CDMA base stations and multi carrier applications in the 800 MHz to 1000 MHz frequency range

## 2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
BLF6G10-13	5RN (SOT502A)		
1	drain		
2	gate		1 
3	source	[1] 2 3	2 — 3 sym112
BLF6G10LS	-135RN (SOT502B)		
1	drain		
2	gate	1	1 
3	source	2 3	2 - 3 sym112

<sup>[1]</sup> Connected to flange.

## 3. Ordering information

Table 3. Ordering information

Type number	Packag	Package		
	Name	Description	Version	
BLF6G10-135RN	-	flanged LDMOST ceramic package; 2 mounting holes; 2 leads	SOT502A	
BLF6G10LS-135RN	-	earless flanged LDMOST ceramic package; 2 leads	SOT502B	

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	65	V
$V_{GS}$	gate-source voltage		-0.5	+13	V
$I_D$	drain current		-	32	Α
T <sub>stg</sub>	storage temperature		-65	+150	°C
$T_j$	junction temperature		-	225	°C

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#### 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Туре	Тур	Unit
$R_{th(j\text{-case})}$		$T_{case}$ = 80 °C; $P_L$ = 25 W	BLF6G10-135RN	0.68	K/W
	junction to case		BLF6G10LS-135RN	0.56	K/W

#### 6. Characteristics

Table 6. Characteristics

 $T_i = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 0.8 \text{ mA}$	65	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10 \text{ V}; I_D = 180 \text{ mA}$	1.4	1.9	2.4	V
$V_{GSq}$	gate-source quiescent voltage	$V_{DS} = 28 \text{ V}; I_D = 950 \text{ mA}$	1.6	2.1	2.6	V
I <sub>DSS</sub>	drain leakage current	$V_{GS} = 0 \text{ V}; V_{DS} = 28 \text{ V}$	-	-	3	μΑ
I <sub>DSX</sub>	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $V_{DS} = 10 \text{ V}$	24	32	-	Α
I <sub>GSS</sub>	gate leakage current	$V_{GS} = 11 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	300	nΑ
9 <sub>fs</sub>	forward transconductance	$V_{DS} = 10 \text{ V}; I_D = 9 \text{ A}$	7	13	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ $I_D = 6.3 \text{ A}$	-	0.1	-	Ω
$C_{rs}$	feedback capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 28 \text{ V};$ f = 1 MHz	-	2.0	-	pF

## 7. Application information

 Table 7.
 Application information

Mode of operation: 2-carrier W-CDMA; PAR 7.5 dB at 0.01 % probability on CCDF; 3GPP test model 1; 1-64 PDPCH;  $f_1$  = 871.5 MHz;  $f_2$  = 876.5 MHz;  $f_3$  = 886.5 MHz;  $f_4$  = 891.5 MHz; RF performance at  $V_{DS}$  = 28 V;  $I_{Dq}$  = 950 mA;  $T_{case}$  = 25 °C; unless otherwise specified; in a class-AB production test circuit.

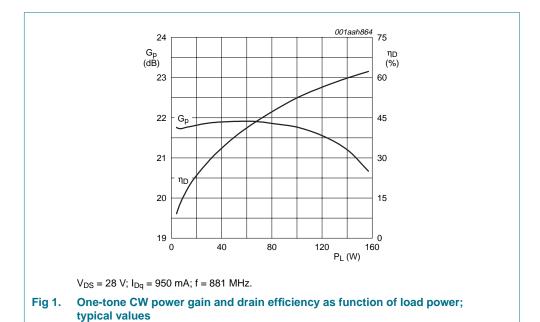
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$P_{L(AV)}$	average output power		-	26.5	-	W
Gp	power gain	$P_{L(AV)} = 26.5 \text{ W}$	20.0	21.0	-	dB
$RL_{in}$	input return loss	$P_{L(AV)} = 26.5 \text{ W}$	-	-10.0	-6.5	dB
$\eta_{D}$	drain efficiency	$P_{L(AV)} = 26.5 \text{ W}$	26.0	28.0	-	%
ACPR	adjacent channel power ratio	$P_{L(AV)} = 26.5 \text{ W}$	-	-39	-36.5	dBc

#### 7.1 Ruggedness in class-AB operation

The BLF6G10-135RN and BLF6G10LS-135RN are capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions:  $V_{DS} = 28 \text{ V}$ ;  $I_{Dq} = 950 \text{ mA}$ ;  $P_{L} = 135 \text{ W}$ ; f = 894 MHz.

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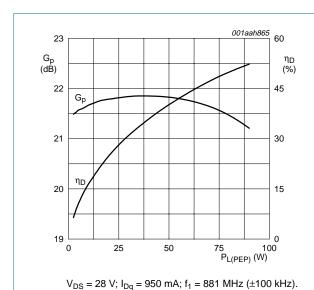
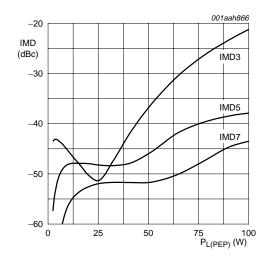


Fig 2. Two-tone CW power gain and drain efficiency as function of peak envelope load power; typical values

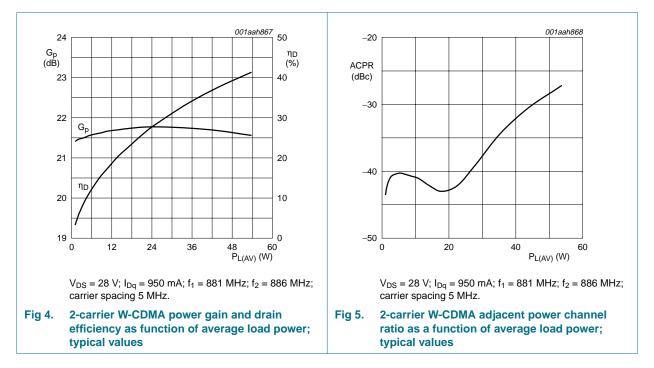


 $V_{DS} = 28 \text{ V}; I_{Dq} = 950 \text{ mA}; f_1 = 881 \text{ MHz } (\pm 100 \text{ kHz}).$ 

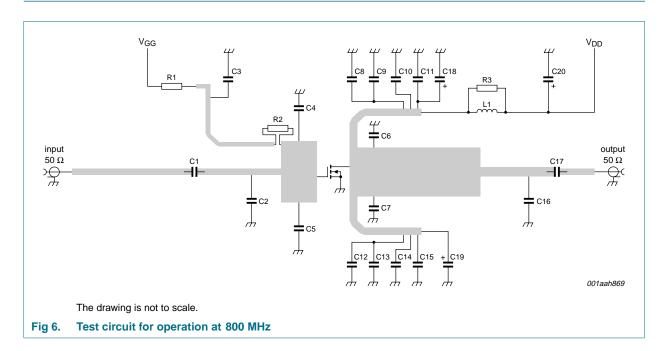
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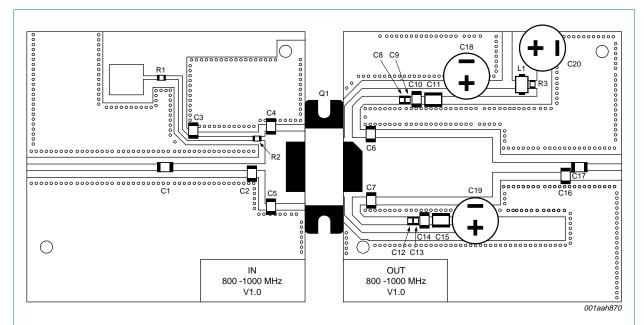
Two-tone CW intermodulation distortion as a Fig 3. function of peak envelope load power; typical values

**Product data sheet** 



## 8. Test information





The striplines are on a double copper-clad Taconic RF35 Printed-Circuit Board (PCB) with  $\epsilon_r$  = 3.5 and thickness = 0.76 mm. See Table 8 for list of components.

The drawing is not to scale.

Fig 7. Component layout

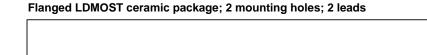
Table 8. List of components See Figure 6 and Figure 7.

Component	Description	Value		Remarks
C1, C3, C10, C14, C17	multilayer ceramic chip capacitor	68 pF	<u>[1]</u>	solder vertically
C2, C4, C5	multilayer ceramic chip capacitor	8.2 pF	<u>[1]</u>	solder vertically
C6, C7	multilayer ceramic chip capacitor	10 pF	<u>[1]</u>	solder vertically
C8, C9, C12, C13	electrolytic capacitor	100 nF		Vishay or capacitor of same quality.
C11, C15	multilayer ceramic chip capacitor	$4.7\mu F;50\;V$	[2]	
C16	multilayer ceramic chip capacitor	3.0 pF	[1]	solder vertically
C18, C19, C20	electrolytic capacitor	220 μF; 63 V		
L1	ferrite SMD bead			Ferroxcube BDS 3/3/4.6-4S2 or equivalent
Q1	BLF6G10LS-135RN			
R1, R2, R3	SMD resistor	9.1 Ω; 0.1 W		

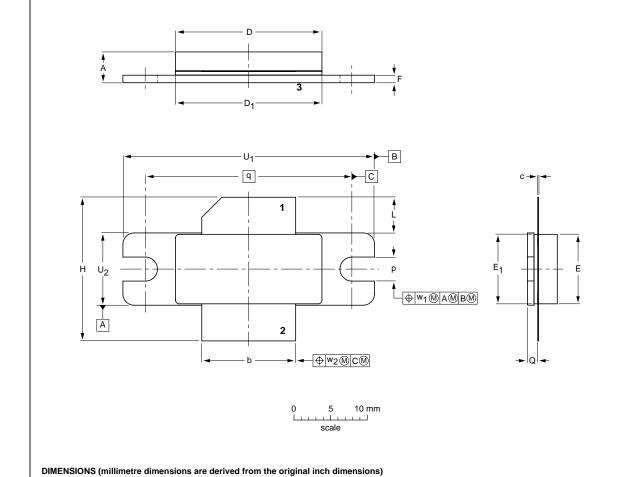
<sup>[1]</sup> American Technical Ceramics type 100B or capacitor of same quality.

[2] TDK or capacitor of same quality.

## 9. Package outline



#### SOT502A



OUTLINE		REFER	ENCES	EUROPEAN	ICCUE DATE	
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE	
SOT502A					<del>-99-12-28</del> 03-01-10	

Н

19.94

18.92

0.045 0.785

0.035 0.745

5.33

4.32

0.210 0.133

3.38

3.12

Q

1.70

1.45

0.067

 $U_1$ 

34.16

33.91

1.345

1.335

q

27.94

 $\mathsf{U}_2$ 

9.91

0.390

w<sub>1</sub>

0.25

w<sub>2</sub>

0.51

0.02

F

1.14

0.89

Fig 8. Package outline SOT502A

С

0.15

0.08

0.006

D

20.02

19.61

0.788 0.786

 $D_1$ 

19.96

19.66

0.774

Ε

9.50

9.30

0.374

0.366

E<sub>1</sub>

9.53

9.25

0.375

0.364

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UNIT

mm

inches

Α

4.72

3.43

0.186

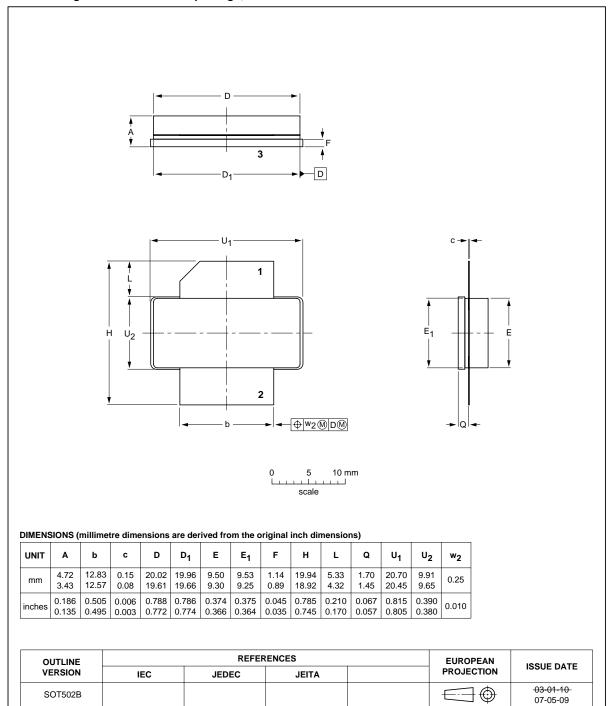
b

12.83

0.505

#### Earless flanged LDMOST ceramic package; 2 leads

SOT502B



Package outline SOT502B

SOT502B

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## 10. Abbreviations

Table 9. Abbreviations

Table 5.	Abbreviations
Acronym	Description
3GPP	Third Generation Partnership Project
CCDF	Complementary Cumulative Distribution Function
CDMA	Code Division Multiple Access
CW	Continuous Wave
DPCH	Dedicated Physical CHannel
EDGE	Enhanced Data rates for GSM Evolution
GSM	Global System for Mobile communications
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor
PAR	Peak-to-Average power Ratio
PDPCH	transmission Power of the Dedicated Physical CHannel
RF	Radio Frequency
SMD	Surface Mounted Device
VSWR	Voltage Standing-Wave Ratio
W-CDMA	Wideband Code Division Multiple Access
	<u> </u>

## 11. Revision history

#### Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF6G10-135RN_10LS-135RN_1	20090210	Product data sheet	-	-

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#### 12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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## **BLF6G10(LS)-135RN**

**Power LDMOS transistor** 

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Date of release: 10 February 2009 Document identifier: BLF6G10-135RN\_10LS-135RN\_1

